Search Notes



Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/763,405	OLECH, LEE	
	Examiner	Art Unit	_
	Jeffrey T. Barton	1753	

SEARCHED					
Class	Subclass	Date	Examiner		
204	450-470	11/14/2005	JTB		
204	600-621	11/14/2005	JTB		
564	248	11/14/2005	JTB		
564	511-512	11/14/2005	JTB		
525	54.111	11/14/2005	JTB		
525	420-421	11/14/2005	JTB		
528	229,324	11/14/2005	JTB		
528	332,339.5	11/14/2005	JTB		
514	634-635	11/14/2005	JTB		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
204	459,548	11/21/2005	JTB		
204	610,644	11/21/2005	JTB		
564	248	11/21/2005	JTB		
Other XRef		11/21/2005	JTB		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See attached EAST	11/14/2005	JTB
Attached STN structure search	11/9/2005	JTB
Attached STIC structure search	11/16/2005	JTB
Inventor name search	. 11/21/2005	JTB
Consultations with Brian Davis (AU 1621) and Ana Woodward (AU 1711) regarding patentability and search strategy.	11/18/2005	JTB
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